

PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000114

Date: 5APR2016 P1/3

	,					
	Semtech Canada Corporation, 4281 Harvester Road, Burlington, Ontario L7L 5M4 Canada					
	Semtech Irvine, 5141 California Ave., Suite 150, Irvine CA 92617					
Semtech Neuchatel Sarl,	Semtech Neuchatel Sarl, Route des Gouttes d'Or 40, CH-2000 Neuchatel Switzerland					
	Nanotech Semiconductor, Semtech Corporation, 2 West Point Court, Bristol, United Kingdom, BS32 4PY					
□ Semtech Corpus Christi S	Semtech Corpus Christi SA de CV, Carretera Matamorros Edificio 7, Reynosa, Tamaulipas, Mexico 88780					
Product Discontinuance Details						
Purpose, Description a	and Effect of Change:					
below. In accordance with S	emtech's product discontinua	s discontinuing the manufactur tion policy, we are hereby givi ne purchases of the disconting	ng notice of these product			
Products purchased under E	OL are subject to No Credit/N	lo Return and are exempt fron	n On-going FA support.			
Product Status: Q Status						
Part Number(s) Affecte μClamp0551Y.TFT RClamp1851Y.TFT RClamp3331Y.TFT RClamp2451Y.TFT	RClamp1851Y.TFT RClamp3331Y.TFT					
Replacement or Altern μClamp0551Y.TFT -> μt RClamp1851Y.TFT -> R RClamp3331Y.TFT -> R RClamp2451Y.TFT -> R	Clamp5011ZATFT Clamp1851ZATFT Clamp3331ZATFT	□ N/A or Not Offered				
Last Time Buy (LTB) Date	2OCT2016	Must Accept Final Delivery by	31MAR2017			
Sample Availability of Alt. Part	5APR2016 ☐ N/A	Qualification Report Availability of Alt. Part	5APR2016 ☐ N/A			
of Alt. Part N/A Availability of Alt. Part N/A Supporting Documents for Alternate or Replacement parts/Attachments: μClamp5011ZA: Product Data Sheet and Qualification Report RClamp1851ZA: Product Data Sheet and Qualification Report RClamp3331ZA: Product Data Sheet and Qualification Report RClamp2451ZA: Product Data Sheet and Qualification Report RClamp2451ZA: Product Data Sheet and Qualification Report						



PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000114

Date: 5APR2016 P2/3

Last Time Buy Conditions

We request you carefully review this information and notify your purchasing offices and buyers to place your company's final purchases for available discontinued products as soon as possible according to the following last time buy terms and conditions.

- Availability: The Last Time Buy Date and Date to Accept Final Delivery are noted above. All
 orders must have a requested ship date before the Date to Accept Final Delivery or the order will
 be rejected. The Last Time Buy Date automatically expires when the final available inventory
 quantity has been scheduled and sold.
- Pricing: The product unit price will be subject to Semtech's individual price quotation of your company's last time buy requirements.

3. Order Acceptance/Change Conditions:

- A. Semtech will accept last time orders from your company for the discontinued products as "Firm and Final". As such, these orders will not be subject to any reschedule, cancellation, or termination by your company without Semtech's prior written authorization and payment of full termination charges.
- B. Semtech reserves its right to make changes in the scheduled delivery dates, or to terminate remaining undelivered quantities of your company's last time buy order, due to changes in Semtech's last time manufacturing capabilities, or for commercially impracticable circumstances which makes delivery not feasible.
- 4. **Quantities:** The following applies to final buy quantities for the available discontinued product:
 - A. **First:** The quantities in any existing unfilled orders and contracts acknowledged by Semtech will be honored, then
 - B. **Next:** The unfilled quantities in any volume agreement(s) or quantities in unexpired standalone quote(s) will be accepted, and
 - C. **Finally:** Any additional reasonable quantity of product that Semtech quotes based upon your company's identified requirements will be taken.

IN THE EVENT OF CONFLICT FOR THE LIMITED AVAILABILITY PRODUCT, QUANTITIES FOR CUSTOMER'S OR DISTRIBUTOR'S ORDERS WILL BE DETERMINED ON A FIRST-COME FIRST-SERVE BASIS; AND WILL BE SUBJECT TO SEMTECH'S AVAILABLE INVENTORY AND REMAINING MANUFACTURING CAPACITY FOR THE PRODUCT.



PRODUCT DISCONTINUANCE NOTIFICATION

EOL-000114

Date: 5APR2016 P3/3

Limited Warranty

All discontinued product orders subject to this notice shall carry Semtech's standard limited warranty; or, if applicable, the warranty set forth in a duly executed formal contract between Semtech and your company will apply; except that:

- 1. Semtech will accept all valid warranty claims for credit only, unless a replacement order is otherwise agreed upon by Semtech and the replacement parts can be manufactured or delivered from remaining inventory.
- 2. The applicable warranty period for making any return claims for discontinued products will be no later than ninety (90) days following delivery of the discontinued products.
- Any return claims must be made under Semtech's current Return Material Authorization "RMA" procedures.

Additional Provisions

SEMTECH ACCEPTS NO LIABILITY FOR EXCESS REPROCUREMENT COSTS OR FOR ANY SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES WHATSOEVER ASSOCIATED WITH THIS NOTICE, WITH ITS PRODUCTS, OR WITH THE FINAL MANUFACTURE AND PERFORMANCE AGAINST ANY LAST TIME BUY ORDERS RELATED TO THE DISCONTINUED PRODUCTS COVERED BY THIS NOTICE.

We regret the inconvenience and impact this notice may cause your company. Semtech's sales, marketing, and distribution personnel stand ready to assist you in placing your company's final orders, or in providing the product information you require.

For product inquiries or purchase order information, please contact your local Semtech sales representative.

Issuing Authority				
Semtech Business Unit:	Protection Business Unit			
Semtech Contact Info:	Les Fang Yuen Senior Manager, Quality Assurance Semtech Corporation Ifangyen@semtech.com; Office: +1 949-269-4443	Les Long ynen		

FOR FURTHER INFORMATION & WORLDWIDE SALES COVERAGE: http://www.semtech.com/contact/index.html#support

RClamp1851ZA Ultra Small RClamp® 1-Line, 18V ESD Protection

PROTECTION PRODUCTS - RailClamp®

Description

RClamp® TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp®1851ZA is specifically designed for protection of Near Field Communications (NFC) interfaces. It features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.16 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-17kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) means that harmonic distortion the the RF signal is minimized. This device is bidirectional and has a working voltage of 18V for use on NFC resonator circuits without signal clipping.

RClamp1851ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablet PC's.

Features

- ◆ High ESD withstand Voltage: +/-17kV (Contact) and +/- 20kV (Air) per IEC 61000-4-2
- ◆ Ultra-small package
- Protects one high speed data line
- Low ESD clamping voltage
- Working voltage: 18V
- Low capacitance: 0.35pF typical
- ◆ Low leakage current
- Extremely low dynamic resistance: 0.16 Ohms (Typ)
- Solid-state silicon-avalanche technology

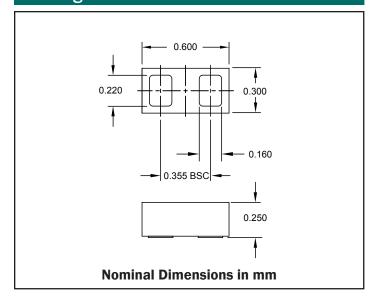
Mechanical Characteristics

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- ◆ Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

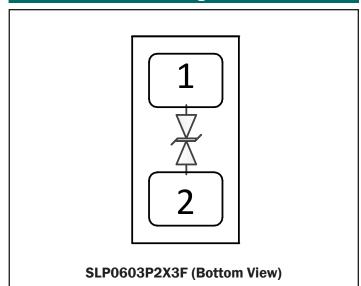
Applications

- Near Field Communication (NFC) lines
- RF signal lines
- Cellular Handsets
- Tablets
- FM Antenna

Package Dimensions



Schematic & Pin Configuration





Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Current (tp = 8/20μs)	I _{PP}	3	Α
ESD per IEC 61000-4-2 (Air) ⁽¹⁾ ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±20 ±17	kV
Operating Temperature	T _J	-40 to +85	°C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V _{RWM}	$T = -40 \text{ to } +85^{\circ}\text{C}$			18	V
Breakdown Voltage	V _{BR}	I _{BR} = 10μA	18.5	22.5	26.5	V
Reverse Leakage Current	I _R	V _{RWM} = 18V		<1	50	nA
ESD Clamping Voltage ²	V _c	$I_{pp} = 4A$ tp = 0.2/100ns		5.5		V
ESD Clamping Voltage ²	V _c	$I_{pp} = 16A$ tp = 0.2/100ns		7.5		V
Dynamic Resistance ^{2, 3}	R _{DYN}	tp = 0.2/100ns		0.16		Ohms
Junction Capacitance	C _J	VR = OV; f = 1MHz		0.35	0.45	pF

Notes

¹⁾Measured with a 40dB attenuator, 50 Ohm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

²⁾Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t1 = 70ns to t2 = 90ns.

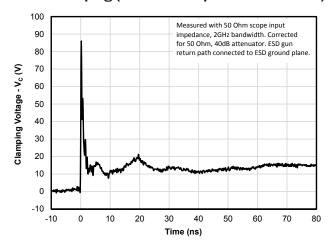
³⁾Dynamic resistance calculated from $\rm I_{\rm TLP}$ = 4A to $\rm I_{\rm TLP}$ = 16A

⁴⁾Device is electrically symmetrical

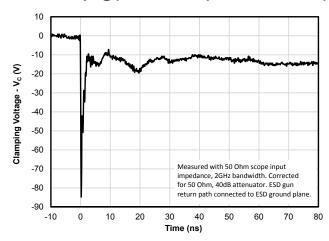


Typical Characteristics

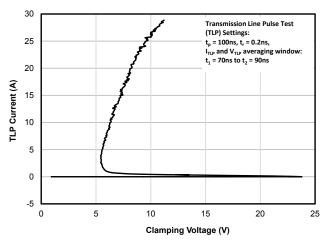
ESD Clamping (8kV Contact per IEC 61000-4-2)



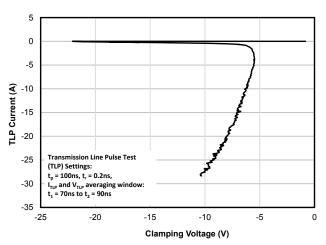
ESD Clamping (-8kV Contact per IEC 61000-4-2)



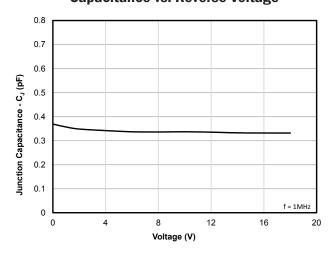
TLP Characteristic (Positive Pulse)



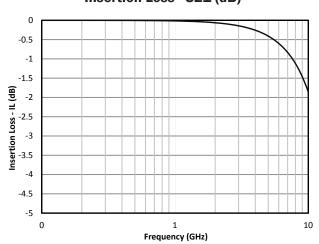
TLP Characteristic (Negative Pulse)



Capacitance vs. Reverse Voltage



Insertion Loss - S21 (dB)





Applications Information

ESD Protection of NFC Interfaces

The Near Field Communication (NFC) antenna is usually connected to the NFC controller IC via contact points on the phone. These contact points are user accessable and therefore may be subjected to ESD strikes. External protection (TVS) devices should be placed between the antenna and the NFC chip interface. The working voltage of the TVS should be high enough as not to clip the NFC signal. Additionally, the capacitance of the device

should be minimized in order to avoid harmonic disctortion of the RF signal. RClamp1851ZA meets these requirements and also features extremely low dynamic resistance resulting in low ESD clamping voltage. The low dynamic resistance also helps insure protection for Schottky diodes that may be used in the NFC circuit. RClamp1851ZA is designed to work on NFC circuits with AC signals as high as 18V. An example protection ciruit is shown below in Figure 1.

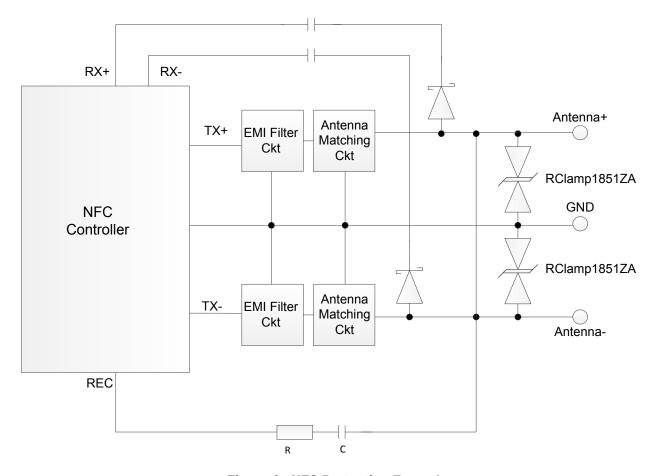


Figure 1 - NFC Protection Example

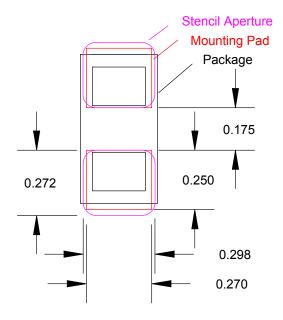


Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The table below provides Semtech's recommended assembly guidelines for mounting this device. The figure at the right details Semtech's recommended aperture based on the below recommendations. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. The exact manufacturing parameters will require some experimentation to get the desired solder application.

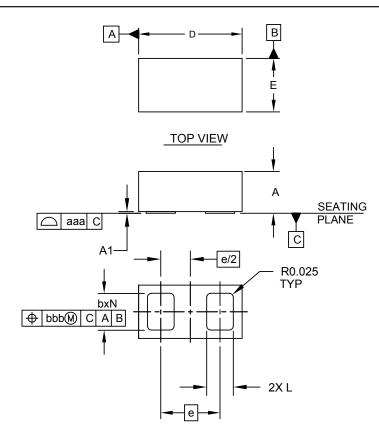
Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



Recommended Mounting Pattern



Outline Drawing - SLP0603P2X3F



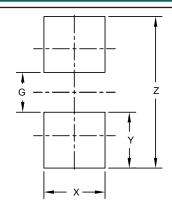
DIMENSIONS				
DIM	MILI	_IMETE	RS	
וווטן	MIN	NOM	MAX	
Α	0.235	0.250	0.265	
A1	0.000	0.010	0.050	
р	0.200	0.220	0.240	
D	0.580	0.600	0.620	
Е	0.280	0.300	0.320	
е	0.355 BSC			
L	0.140	0.160	0.180	
Ζ	2			
aaa	0.08			
bbb	0.10			

BOTTOM VIEW

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).

Land Pattern - SLP0603P2X3F



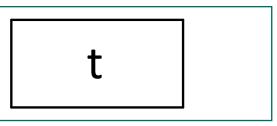
	DIMENSIONS		
DIM	DIM MILLIMETERS		
G	0.177		
Х	0.272		
Υ	0.247		
Z	0.671		

NOTES:

CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES). THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY.
CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR
COMPANY'S MANUFACTURING GUIDELINES ARE MET.



Marking



Notes: Device is Electrically Symmetrical

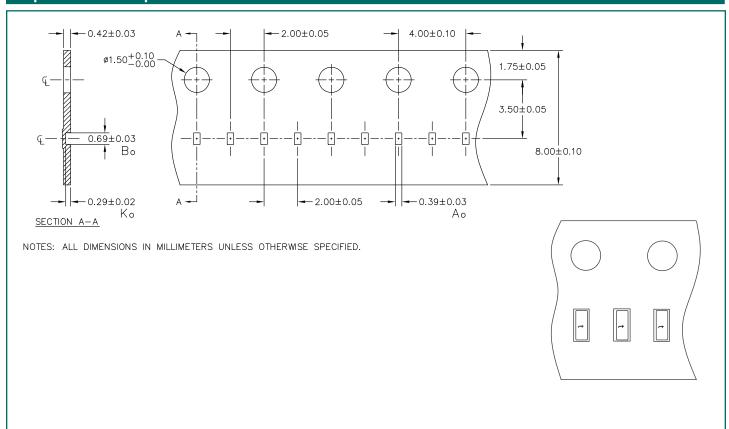
Ordering Information

Part Number	Qty per Reel	Reel Size	
RClamp1851ZATFT	15000	7"	

Notes:

1) RailClamp and RClamp are trademarks of Semtech Corporation.

Tape and Reel Specification



Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804

RClamp2451ZA Ultra Small RailClamp® 1-Line, 24V ESD Protection

PROTECTION PRODUCTS - RailClamp®

Description

RailClamp® TVS diodes are ultra low capacitance devices designed to protect sensitive electronics from damage or latch-up due to ESD, EFT, and EOS. They are designed for use on high speed ports in applications such as cell phones, notebook computers, and other portable electronics. These devices offer desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp®2451ZA is specifically designed for protection of Near Field Communications (NFC) interfaces. It features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.16 Ohms (typical), low peak ESD clamping voltage, and high ESD withstand voltage (+/-14kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) means that RClamp2451ZA will not create harmonic distortion in the RF signal. This device is bidirectional and has a working voltage of 24V for use on NFC resonator circuits without signal clipping.

RClamp2451ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of 0.25mm. Leads are finished with lead-free NiAu. The combination of working voltage, low dynamic resistance, and low capacitance makes this device ideal for use on NFC antenna ciruits, RF signal lines, and FM antennas in portable devices.

Features

- ◆ High ESD withstand Voltage: +/-14kV (Contact) and +/- 18kV (Air) per IEC 61000-4-2
- Able to withstand over 1000 ESD strikes per IEC 61000-4-2 Level 4
- Ultra-small 0201 package
- ◆ Protects one high speed data line
- ◆ Working voltage: +/- 24V
- Low capacitance: 0.35pF typical
- ◆ Low dynamic resistance: **0.16 Ohms (Typ)**
- ◆ Low ESD clamping voltage
- Solid-state silicon-avalanche technology

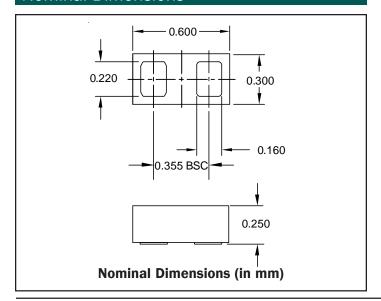
Mechanical Characteristics

- ◆ SLP0603P2X3F Package
- ◆ Pb-Free, Halogen Free, RoHS/WEEE Compliant
- ◆ Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- ◆ Lead Finish: NiAu
- Marking: Marking Code
- ◆ Packaging: Tape and Reel

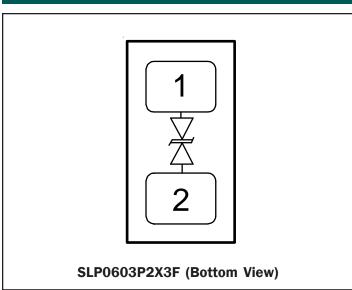
Applications

- ◆ Near Field Communication (NFC) lines
- RF signal lines
- ◆ FM Antenna

Nominal Dimensions



Schematic





Absolute Maximum Rating	
Rating	

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20μs)	P_{pk}	60	Watts
Maximum Peak Pulse Current (tp = 8/20μs)	I _{pp}	3	Amps
ESD per IEC 61000-4-2 (Air) ¹ ESD per IEC 61000-4-2 (Contact) ¹	V _{ESD}	+/- 18 +/- 14	kV
Operating Temperature	T,	-40 to +85	°C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units
Reverse Stand-Off Voltage	V _{RWM}	Pin 1 to 2 or 2 to 1			24	V
Breakdown Voltage	V_{BR}	I _{BR} = 10μΑ	25.5	27.5	31	V
Reverse Leakage Current	I _R	V _{RWM} = 24V, T=25°C Pin 1 to 2 or 2 to 1		<1	50	nA
ESD Clamping Voltage ²	V _c	$I_{pp} = 4A,$ tlp = 0.2/100ns		5		V
ESD Clamping Voltage ²	V _c	$I_{pp} = 16A,$ tlp = 0.2/100ns		7		V
Dynamic Resistance ^{2, 3}	R _D	tp = 0.2/100ns		0.16		Ohms
Junction Capacitance	C _j	V _R = OV, f = 1MHz		0.35	0.45	pF

Notes

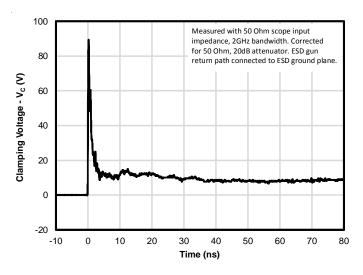
¹⁾ESD gun return path connected to ESD ground reference plane. 2)Transmission Line Pulse Test (TLP) Settings: t_p = 100ns, t_r = 0.2ns, l_{TLP} and V_{TLP} averaging window: t_1 = 70ns to $t_2 = 90 \text{ ns.}$

 $[\]stackrel{2}{\text{3}}$) Dynamic resistance calculated from I_{TLP} = 4A to I_{TLP} = 16A

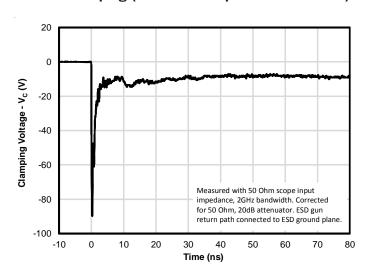


Typical Characteristics

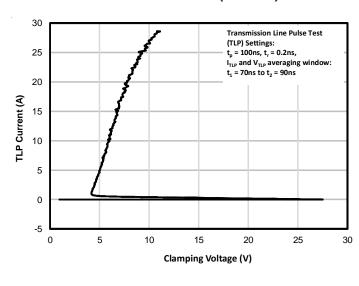
ESD Clamping (+8kV Contact per IEC 61000-4-2)



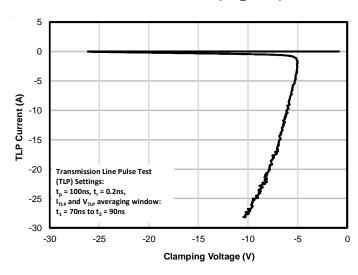
ESD Clamping (-8kV Contact per IEC 61000-4-2)



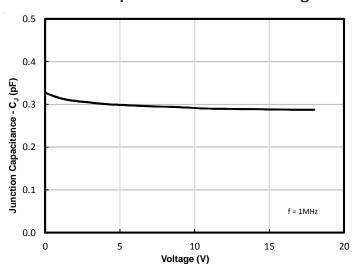
TLP Characteristic (Positive)



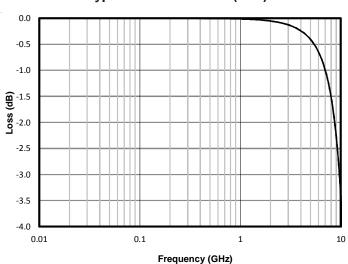
TLP Characteristic (Negative)



Junction Capacitance vs. Reverse Voltage



Typical Insertion Loss (S21)





Applications Information

ESD Protection of NFC Interfaces

The Near Field Communication (NFC) antenna is usually connected to the NFC controller IC via contact points on the phone. These contact points are user accessable and therefore may be subjected to ESD strikes. External protection (TVS) devices should be placed between the antenna and the NFC chip interface. The working voltage of the TVS should be high enough as not to clip the NFC signal. Additionally, the capacitance of the device should be minimized in order to avoid harmonic distortion of the RF signal. RClamp2451ZA meets these requirements and also features extremely low dynamic resistance (<0.1 Ohms) resulting in low ESD clamping voltage. The low dynamic resistance also helps insure protection for Schottky diodes that may be used in the NFC circuit. RClamp2451ZA is designed to work on NFC circuits with AC signals as high as 24V. An example protection ciruit using RClamp2451ZA is shown below in Figure 1.

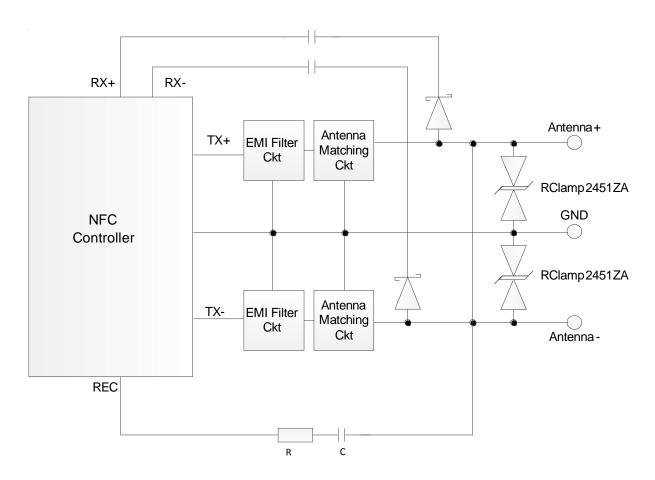


Figure 1 - NFC Protection Example

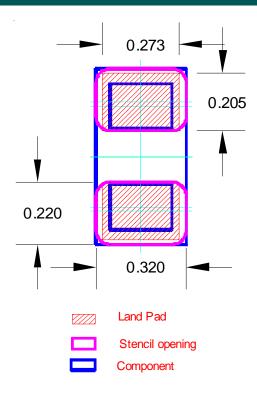


Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joints. The figure at the right details Semtech's recommended aperture based on the assembly guidelines detailed in the table below. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application.

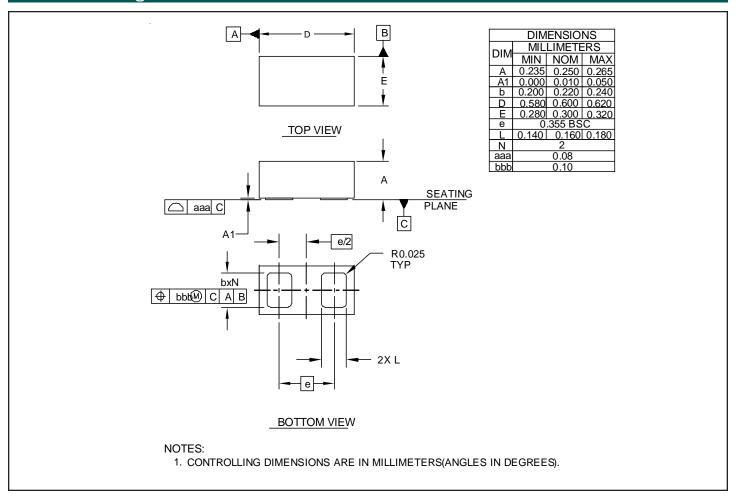
Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



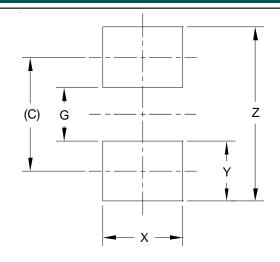
Recommended Mounting Pattern



Outline Drawing - SLP0603P2X3F



Land Pattern - SLP0603P2X3F



	DIMENSIONS
DIM	MILLIMETERS
С	(0.385)
G	0.181
Х	0.273
Υ	0.205
Z	0.590

NOTES:

- 1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
- 2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY . CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET .



Marking Code

Ordering Information

Part Number	Qty per	Pocket	Reel
	Reel	Pitch	Size
RClamp2451ZATFT	15,000	2mm	7 Inch

e

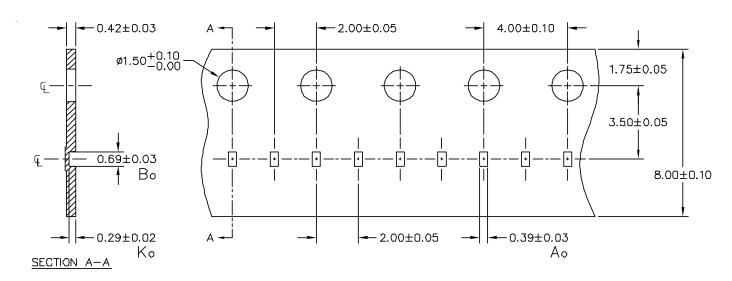
Notes:

RailClamp and RClamp are trademarks of Semtech Corporation

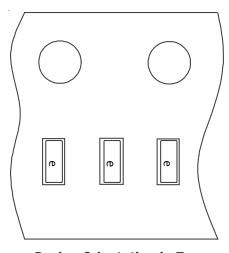
Note:

Device is electrically symmetrical

Carrier Tape Specification



NOTES: ALL DIMENSIONS IN MILLIMETERS UNLESS OTHERWISE SPECIFIED.



Device Orientation in Tape



Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804

RClamp3331ZA Ultra Small RailClamp® 1-Line, 3.3V ESD Protection

PROTECTION PRODUCTS - RailClamp®

Description

RailClamp® TVS diodes are ultra low capacitance devices designed to protect sensitive electronics from damage or latch-up due to ESD, EFT, and EOS. They are designed for use on high speed ports in applications such as cell phones, notebook computers, and other portable electronics. These devices offer desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp®3331ZA features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.20 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-18kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) allows the RClamp3331ZA to be used in applications operating in excess of 5GHz without appreciable signal attenuation. Each device will protect one high speed data line operating at 3.3 Volts.

RClamp3331ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of 0.25mm. Leads are finished with lead-free NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of low peak ESD clamping, low dynamic resistance, and low capacitance makes this device suitable for applications such as USB 3.0, MIPI and V-By-One interfaces in portable devices.

Features

- ◆ High ESD withstand Voltage: +/-18kV (Contact/Air) per IEC 61000-4-2
- ◆ Able to withstand over 1000 ESD strikes per IEC 61000-4-2 Level 4
- Ultra-small 0201 package
- Protects one high speed data line
- Working voltage: +/- 3.3V
- Low capacitance: 0.35pF typical
- ◆ Extremely low dynamic resistance: **0.20 Ohms (Typ)**
- Low ESD clamping voltage
- Solid-state silicon-avalanche technology

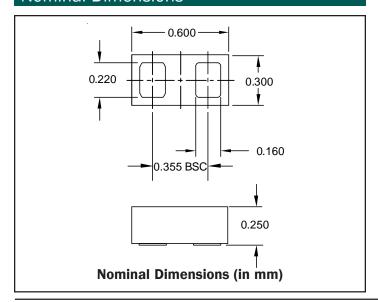
Mechanical Characteristics

- SLP0603P2X3F Package
- ◆ Pb-Free, Halogen Free, RoHS/WEEE Compliant
- ◆ Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- ◆ Lead Finish: NiAu
- Marking: Marking Code
- Packaging: Tape and Reel

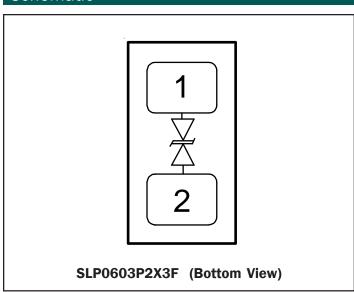
Applications

- ◆ USB 2.0 / USB 3.0
- ◆ MIPI / MDDI
- ◆ V-By-One
- eDP
- MHL
- LVDS

Nominal Dimensions



Schematic





Absolute Maximum Rating			
Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20μs)	P _{pk}	30	Watts
Maximum Peak Pulse Current (tp = 8/20µs)	I _{pp}	4	Amps
ESD per IEC 61000-4-2 (Air) ¹ ESD per IEC 61000-4-2 (Contact) ¹	V _{ESD}	+/- 18 +/- 18	kV
Operating Temperature	T _J	-40 to +85	°C
Storage Temperature	Т	-55 to +150	°C

Electrical Characteristics (T=25°C)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units
Reverse Stand-Off Voltage	V _{RWM}	Pin 1 to 2 or 2 to 1			3.3	V
Breakdown Voltage	V_{BR}	I _{BR} = 10μA Pin 1 to 2 or 2 to 1	5.5	8	10.5	V
Reverse Leakage Current	I _R	V _{RWM} = 3.3V, T=25°C Pin 1 to 2 or 2 to 1		<1	50	nA
Clamping Voltage	V _c	I _{PP} = 1A, tp = 8/20µs Pin 1 to 2 or 2 to 1		3.8	5.5	V
Clamping Voltage	V _c	I _{PP} = 4A, tp = 8/20µs Pin 1 to 2 or 2 to 1		5.5	7.5	V
ESD Clamping Voltage ²	V _c	IPP = 4A, tlp = 0.2/100ns		4.5		V
ESD Clamping Voltage ²	V _c	IPP = 16A, tlp = 0.2/100ns		7		V
Dynamic Resistance ^{2, 3}	R _D	tp = 0.2/100ns		0.20		Ohms
Junction Capacitance	C _i	$V_R = OV, f = 1MHz$		0.35	0.45	pF

Notes

¹⁾ESD gun return path connected to ESD ground reference plane.

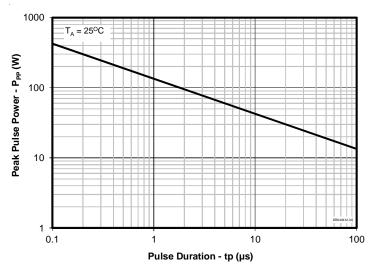
²⁾Transmission Line Pulse Test (TLP) Settings: $t_p = 100$ ns, $t_r = 0.2$ ns, I_{TLP} and V_{TLP} averaging window: $t_1 = 70$ ns to $t_2 = 90$ ns.

 $[\]overline{3}$) Dynamic resistance calculated from $I_{TLP} = 4A$ to $I_{TLP} = 16A$

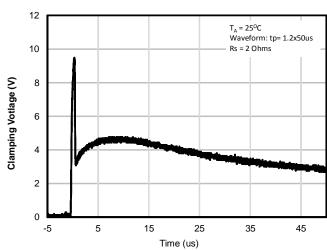


Typical Characteristics

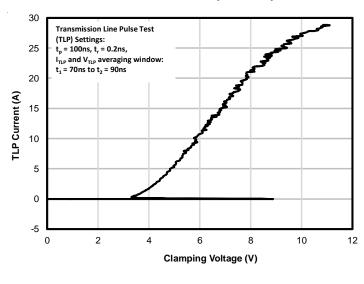
Non-Repetitive Peak Pulse Power vs. Pulse Time



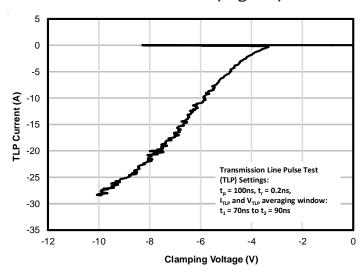
Clamping Waveform (tp=1.2/50us)



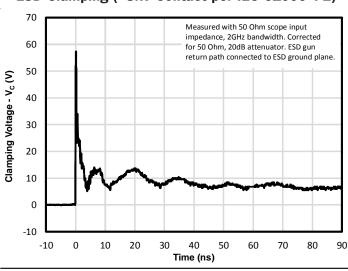
TLP Characteristic (Positive)



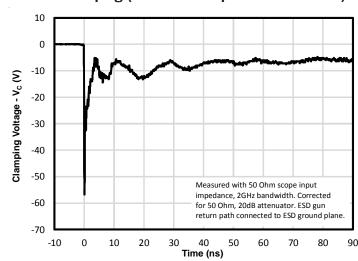
TLP Characteristic (Negative)



ESD Clamping (+8kV Contact per IEC 61000-4-2)



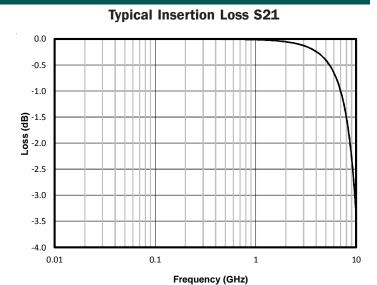
ESD Clamping (-8kV Contact per IEC 61000-4-2)





Typical Characteristics

Junction Capacitance vs. Reverse Voltage 8.0 0.7 0.6 Junction Capacitance - C_J (pF) 0.5 0.4 0.3 0.2 0.1 f = 1MHz 0 0.5 1 1.5 2.5 3 Voltage (V)



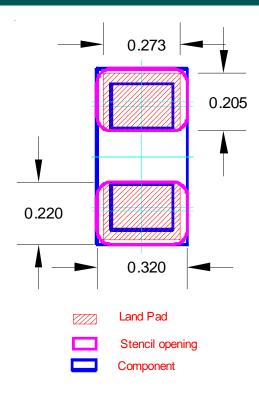


Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joints. The figure at the right details Semtech's recommended aperture based on the assembly guidelines detailed in the table below. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application.

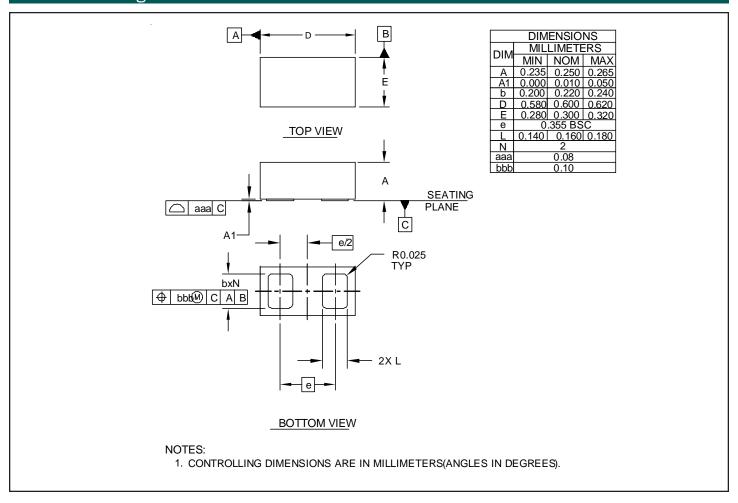
Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



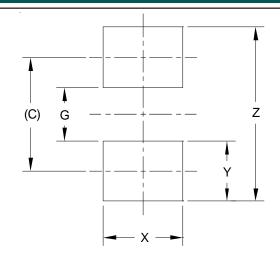
Recommended Mounting Pattern



Outline Drawing - SLP0603P2X3F



Land Pattern - SLP0603P2X3F



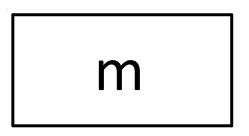
DIMENSIONS		
DIM	MILLIMETERS	
С	(0.385)	
G	0.181	
Χ	0.273	
Υ	0.205	
Z	0.590	

NOTES:

- 1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
- 2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY . CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET .



Marking Code



Ordering Information

Part Number	Qty per	Pocket	Reel
	Reel	Pitch	Size
RClamp3331ZATFT	15,000	2mm	7 Inch

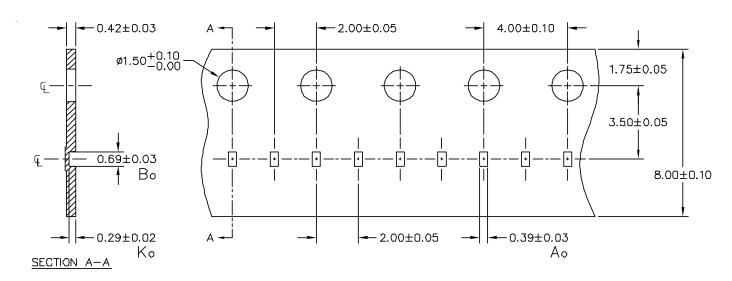
Notes:

RailClamp and RClamp are trademarks of Semtech Corporation

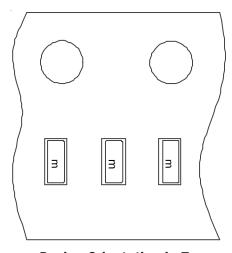
Note:

Device is electrically symmetrical

Carrier Tape Specification



NOTES: ALL DIMENSIONS IN MILLIMETERS UNLESS OTHERWISE SPECIFIED.



Device Orientation in Tape



Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804

μClamp5011ZA Ultra Small μClamp® 1-Line, 5V ESD Protection

PROTECTION PRODUCTS - μClamp®

Description

μClamp® TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace 0201 size multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. It features large cross-sectional area junctions for conducting high transient currents. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

 μ Clamp®5011ZA features extremely good ESD protection characteristics highlighted by low typical dynamic resistance of 0.15 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-15kV contact per IEC 61000-4-2). Low maximum capacitance (5pF at VR=0V) minimizes loading on sensitive cirucuits. Each device will protect one data or power line operating at 5 Volts.

 μ Clamp5011ZA is in a 2-pin SLP0603P2X3F package. It measures 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablet PC's.

Features

- ◆ High ESD withstand Voltage: +/-15kV (Contact) and +/- 18kV (Air) per IEC 61000-4-2
- Ultra-small package
- Protects one data line
- Low ESD clamping voltage
- Working voltage: 5V
- Low capacitance: 5pF maximum
- ◆ Low leakage current
- ◆ Extremely low dynamic resistance: 0.15 Ohms (Typ)
- Solid-state silicon-avalanche technology

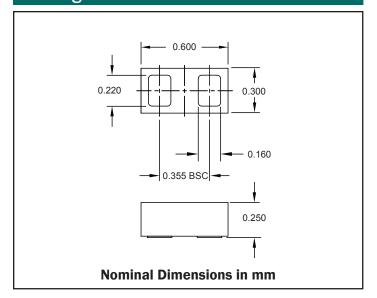
Mechanical Characteristics

- SLP0603P2X3F package
- ◆ Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

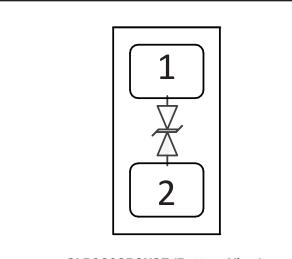
Applications

- Cellular Handsets & Accessories
- Notebook Computers
- ◆ Tablet PC
- Portable Instrumentation
- Peripherals

Package Dimensions



Schematic & Pin Configuration



SLP0603P2X3F (Bottom View)



Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20µs)	P _{PK}	30	W
Peak Pulse Current (tp = 8/20µs)	I _{PP}	2.5	А
ESD per IEC 61000-4-2 (Air) ⁽¹⁾ ESD per IEC 61000-4-2 (Contact) ⁽¹⁾	V _{ESD}	±18 ±15	kV
Operating Temperature	T _J	-40 to +125	°C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	$V_{_{\mathrm{RWM}}}$	Pin 1 to 2 or Pin 2 to 1				5	V
Reverse breakdown Voltage	$V_{_{\mathrm{BR}}}$	I _{BR} = 1mA Pin 1 to 2 or Pin 2 to 1		6.5	8.5	10.5	V
Reverse Leakage Current	I _R	V _{RWM} = 5V Pin 1 to 2 or Pin 2 to 1			5	20	nA
Clamping Voltage	V _c	$I_{pp} = 2.5A, tp = 8/20\mu s$				12	V
ESD Clamping Voltage ²	V _c	I _{PP} = 4A tp = 0.2/100ns			8		V
ESD Clamping Voltage ²	V _c	I _{PP} = 16A tp = 0.2/100ns			9.8		V
Dynamic Resistance ^{2, 3}	R _{DYN}	tp = 100ns			0.15		Ohms
Junction Capacitance	C _J	I/O pin to GND $f = 1MHz$ $V_R = 0V$			4.2	5	pF

Notes

¹⁾Measured with a 20dB attenuator, 50 0hm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

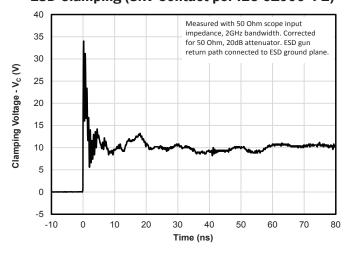
²⁾Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: t1 = 70ns to t2 = 90ns.

³⁾ Dynamic resistance calculated from $I_{TLP} = 4A$ to $I_{TLP} = 16A$

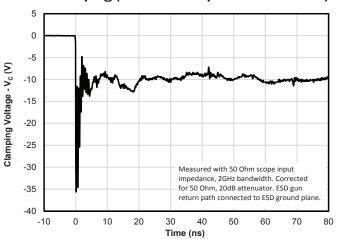


Typical Characteristics

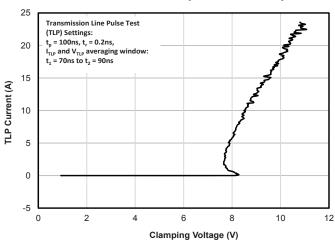
ESD Clamping (8kV Contact per IEC 61000-4-2)



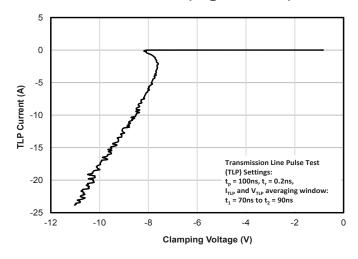
ESD Clamping (-8kV Contact per IEC 61000-4-2)



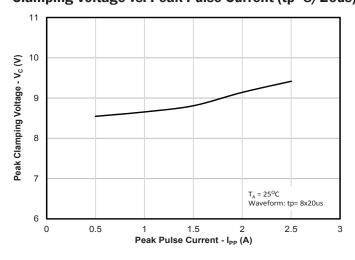
TLP Characteristic (Positive Pulse)



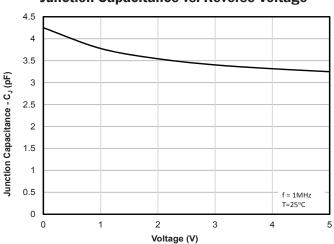
TLP Characteristic (Negative Pulse)



Clamping Voltage vs. Peak Pulse Current (tp=8/20us)



Junction Capacitance vs. Reverse Voltage



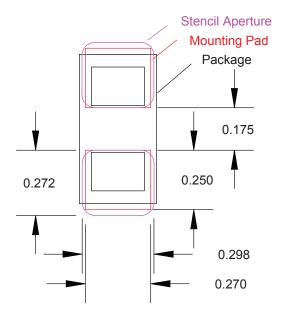


Applications Information

Assembly Guidelines

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The table below provides Semtech's recommended assembly guidelines for mounting this device. The figure at the right details Semtech's recommended aperture based on the below recommendations. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. The exact manufacturing parameters will require some experimentation to get the desired solder application.

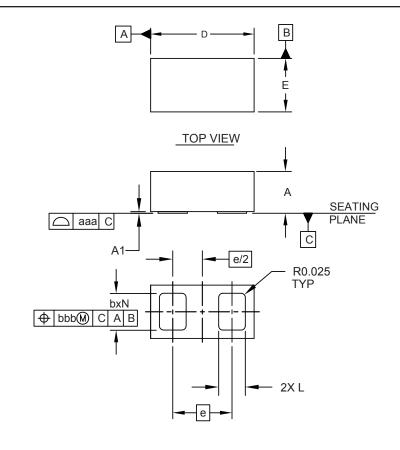
Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



Recommended Mounting Pattern



Outline Drawing - SLP0603P2X3F



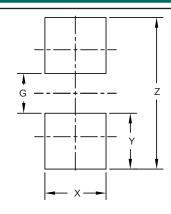
	DIMENSIONS		
		IMETE	
DIM	MIN	NOM	MAX
Α	0.235	0.250	0.265
A1	0.000	0.010	0.050
b	0.200	0.220	0.240
О	0.580	0.600	0.620
Е	0.280	0.300	0.320
е	0.	355 BS	C
L	0.140		0.180
Ν		2	
aaa		0.08	
bbb		0.10	

BOTTOM VIEW

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).

Land Pattern - SLP0603P2X3F



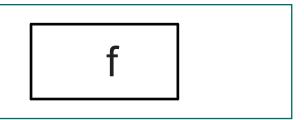
DIMENSIONS		
DIM	MILLIMETERS	
G	0.177	
Χ	0.272	
Υ	0.247	
Z	0.671	

NOTES:

CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY.
CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR
COMPANY'S MANUFACTURING GUIDELINES ARE MET.



Marking



Notes: Device is Electrically Symmetrical

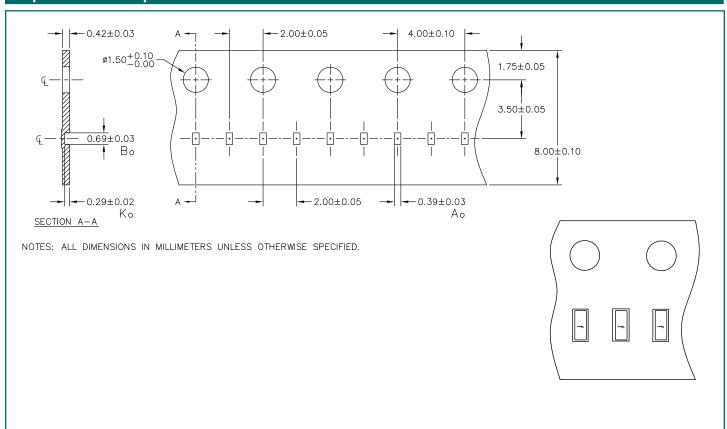
Ordering Information

Part Number	Qty per Reel	Reel Size
μClamp5011ZATFT	15000	7"

Notes:

1) MicroClamp, uClamp and μ Clamp are trademarks of Semtech Corporation.

Tape and Reel Specification



Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804

by Sublot, by Sequence Contact: Gurmail Sajjan (805) 480 2142 gsajjan@semtech.com

Businessunit	Protection				
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:	
5878	uClamp0551Z, uClamp5011Z	ASMC12TVS	Rel Testing Complete	Job Accepted: 22-Aug-2014	
	Package (Z1A) Qualification	Z1A	Passes All Requirements	Requested CD:	
	5 ()	2.7.		Actual Start Date: 27-Aug-2014	
	New Product on qualified process with unqualified package			ECD for Conditional:	
				Job ECD: 22-Oct-2014	

Completed Tasks

1.0 Lot EP338580	AssemblyLot	AER-002012	DateCode	1434			
Seq TaskCode	Sa	ımpleSize	Criteria	Complete	Failures	DataSource	Results/Comments
1 Data-Prep	No	ne	None	27-Aug-2014	0	Camarillo	
2 HTRB_Pre_Elect_150°C	_RT24 21	0	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
3 HTRB_150°C_Real Time	e_0024 21	0	Pass on Zero Fails	09-Sep-2014	0	Camarillo	
4 HTRB_Pre_Elect	10	5	Pass on Zero Fails	27-Aug-2014	0	Camarillo	
5 BI_BD_Valid	NA	A	Meet HTOL Schematics	28-Aug-2014	0	Camarillo	
6 HTRB_150°C_0072	10	5	Pass on Zero Fails	02-Sep-2014	0	Camarillo	
7 HTRB_150°C _0408	10	5	Pass on Zero Fails	15-Sep-2014	0	Camarillo	
8 HTS_Pre_Elect	77		Pass on Zero Fails	27-Aug-2014	0	Camarillo	
9 HTS_0168	77		Pass on Zero Fails	03-Sep-2014	0	Camarillo	
10 HTS_0500	77		Pass on Zero Fails	17-Sep-2014	0	Camarillo	
11 HTS_1000	77		Pass on Zero Fails	08-Oct-2014	0	Camarillo	
12 Pre_Conditioning_Level_	_1 NA	٨	MSL 1	27-Aug-2014	0	Camarillo	
13 Rider_Card_Wash/Bake				27-Aug-2014	0	Camarillo	
14 Pre_Elect_Precond	15	4	Pass on Zero Fails	28-Aug-2014	0	Camarillo	
15 Precond_Temp_Cyc_5c	yc 15	4	Pass on Zero Fails	28-Aug-2014	0	Camarillo	

by Sublot, by Sequence Contact: Gurmail Sajjan (805) 480 2142 gsajjan@semtech.com

16 Precond_HTS_24hr	154	Pass on Zero Fails	29-Aug-2014	0	Camarillo	
17 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
18 Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
19 T/C_Pre_Elect	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
20 T/C_wPre_0250	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
21 T/C_wPre_0500	77	Pass on Zero Fails	16-Sep-2014	0	Camarillo	
22 T/C_wPre_1000	77	Pass on Zero Fails	26-Sep-2014	0	Camarillo	
23 85/85_Pre Elec	77	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
24 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo	
25 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo	
26 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo	
27 Pack_Clos	0	0	22-Oct-2014	0	Camarillo	
2.0 Lot EP3300.01 Assemb	blyLot AER-002017	DateCode	1435			
200 21 0000.01	•					
Seq TaskCode	SampleSize	Criteria	Complete 1	Failures	DataSource	Results/Comments
	<u> </u>			Failures 0	DataSource Camarillo	Results/Comments
Seq TaskCode	SampleSize	Criteria	Complete 1			Results/Comments
Seq TaskCode 1 Data-Prep	SampleSize None	Criteria None	Complete 03-Sep-2014	0	Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24	SampleSize None 210	Criteria None Pass on Zero Fails	03-Sep-2014 10-Sep-2014	0	Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024	SampleSize None 210 210	Criteria None Pass on Zero Fails Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014	0 0 0	Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect	SampleSize None 210 210 105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014	0 0 0	Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid	None 210 210 105 NA	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014	0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072	SampleSize None 210 210 105 NA 105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014	0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408	SampleSize None 210 210 105 NA 105 105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014 22-Sep-2014	0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect	SampleSize None 210 210 105 NA 105 105 77	None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014 22-Sep-2014 03-Sep-2014	0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect 9 HTS_0168	SampleSize None 210 210 105 NA 105 105 77	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014 22-Sep-2014 03-Sep-2014	0 0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect 9 HTS_0168 10 HTS_0500	SampleSize None 210 210 105 NA 105 105 77 77	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails	03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014 22-Sep-2014 03-Sep-2014 10-Sep-2014 24-Sep-2014	0 0 0 0 0 0 0	Camarillo	Results/Comments

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	14 Precond_HTS_24hr	77	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
	15 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
	16 Precond_IR_Refl_Char	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
	17 T/C_Pre_Elect	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
	18 T/C_wPre_0250	77	Pass on Zero Fails	17-Sep-2014	0	Camarillo	
	19 T/C_wPre_0500	77	Pass on Zero Fails	22-Sep-2014	0	Camarillo	
	20 T/C_wPre_1000	77	Pass on Zero Fails	02-Oct-2014	0	Camarillo	
	21 85/85_Pre Elec	77	Pass on Zero Fails	03-Sep-2014	0	Camarillo	
	22 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo	
	23 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo	
	24 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo	
	25 FA_85/85_0168hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	12-Sep-2014	0	Camarillo	Continued to 500 hrs for further evaluation
	26 FA_85/85_0500hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	29-Sep-2014	0	Camarillo	Continuing to 1000 hrs for final evaluation.
	27 FA_85/85_1000hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	21-Oct-2014	0	Camarillo	Discounted, borderline passing at T0 marginally shifted due to tester variance.
	28 Pack_Clos	0	0	22-Oct-2014	0	Camarillo	
3.0	Lot EP3300.01 AssemblyL	ot AER-002018	DateCode	1435			
	Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
	1 Data-Prep	None	None	05-Sep-2014	0	Camarillo	
	2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
	3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	12-Sep-2014	0	Camarillo	
	4 HTRB_Pre_Elect	105	Pass on Zero Fails	05-Sep-2014	0	Camarillo	

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5 BI_BD_Valid	NA	Meet HTOL Schematics	05-Sep-2014	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	08-Sep-2014	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	22-Sep-2014	0	Camarillo
8 HTS_Pre_Elect	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo
9 HTS_0168	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo
10 HTS_0500	77	Pass on Zero Fails	26-Sep-2014	0	Camarillo
11 HTS_1000	77	Pass on Zero Fails	21-Oct-2014	0	Camarillo
13 Pre_Elect_Precond	77	Pass on Zero Fails	10-Sep-2014	0	Camarillo
14 Precond_Temp_Cyc_5cyc	77	Pass on Zero Fails	10-Sep-2014	0	Camarillo
15 Precond_HTS_24hr	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo
16 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
17 Precond_IR_Refl_Char	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
18 T/C_Pre_Elect	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
19 T/C_wPre_0250	77	Pass on Zero Fails	23-Sep-2014	0	Camarillo
20 T/C_wPre_0500	77	Pass on Zero Fails	29-Sep-2014	0	Camarillo
21 T/C_wPre_1000	77	Pass on Zero Fails	09-Oct-2014	0	Camarillo
22 85/85_Pre Elec	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo
23 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo
24 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo
25 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo
26 Pack_Clos	0	0	22-Oct-2014	0	Camarillo

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Eqpvcev<'I wto chiUcllcp''''
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i ucllcpB ugo vgej (kqo '''

Dwukp guuwp kv	Protection			
Tgnqd%	Rct vaP wo dgt.'Lqd'P co gIV{rg	Hcd.'Rcenci g	TgnLqd'Ux wu	Mg{'Fcvgu<
5884	RClamp2451ZA	Tower	Active Rel Job	Lqd'Ceegrvgf < 09-Sep-2014
	RClamp2451ZA New Device Qual	SLP0603P2X3F		Tgs wgragf 'EF<
	New Product on qualified process and		"	CenwerUnctvFc ug< 01-Oct-2014
	qualified package			GEF'hqt 'Eqpf kdqpcıκ
"				'Lqd'GEF<'23-Oct-2014

Eqo rigygf 'Vcumu

1.0 Nqv AER2065 Cungo dr(Ng	7v AER-002065	FcvgEqfg	1439			
Ugs VcunEqf g	Uco rigUk/g	Et kigt kc	Eqo rigig	Hc kwt gu	Fcw Uqwt eg	TguwwulEqo o gpw
1 Data-Prep	None	None	01-Oct-2014	0	Camarillo	
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	01-Oct-2014	0	Camarillo	
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	22-Oct-2014	0	Camarillo	
4 HTRB_Pre_Elect	105	Pass on Zero Fails	01-Oct-2014	0	Camarillo	
5 BI_BD_Valid	NA	Meet HTOL Schematics	01-Oct-2014	0	Camarillo	
6 HTRB_150°C_0072	105	Pass on Zero Fails	06-Oct-2014	0	Camarillo	
7 HTRB_150°C _0408	105	Pass on Zero Fails	20-Oct-2014	0	Camarillo	
8 85/85_Pre Elec	20	Pass on Zero Fails	01-Oct-2014	0	Camarillo	
9 85/85_120hr_On/Off	20	Pass on Zero Fails	06-Oct-2014	0	Camarillo	
10 Pack_Clos	0	0	23-Oct-2014	0	Camarillo	

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Businessunit	Protection				
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:	
5929	RClamp1851ZA	Tower	Rel Testing Complete	Job Accepted: 21-Jan-2015	
	New Device Qual	SLP0603P2X3F	Passes All Requirements	Requested CD:	
		GEI GOGGI ZAGI		Actual Start Date: 17-Dec-2014	
	New Product on qualified process and qualified package		•	ECD for Conditional:	
				Job ECD: 19-Mar-2015	

Completed Tasks

1.0 Lot AER2241	AssemblyLot	AER2241	DateCode	1504			
Seq TaskCode	S	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
1 Data-Prep	N	lone	None	19-Feb-2015		Camarillo	
2 HTRB_Pre_Elect_150°C_	RT24 2	110	Pass on Zero Fails	20-Feb-2015	0	Camarillo	
3 HTRB_150°C_Real Time	_0024 2	110	Pass on Zero Fails	06-Mar-2015	0	Camarillo	
4 HTRB_Pre_Elect	1	05	Pass on Zero Fails	19-Feb-2015	0	Camarillo	
5 HTRB_150°C_0072	1	05	Pass on Zero Fails	23-Feb-2015	0	Camarillo	
6 HTRB_150°C _0408	1	05	Pass on Zero Fails	06-Mar-2015	0	Camarillo	
7 85/85_Pre Elec	2	20	Pass on Zero Fails	19-Feb-2015	0	Camarillo	
8 85/85_120hr_On/Off	2	20	Pass on Zero Fails	24-Feb-2015	0	Camarillo	
9 Pack_Clos	0	1	0	07-Mar-2015		Camarillo	

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Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
5930	RClamp3331ZA	Tower	Finished Creating	Job Accepted: 21-Jan-2015
	New Device Qual	SLP0603P2X3F	Reliability Test Plan	Requested CD:
		02. 0000. 2 7.0.		Actual Start Date: 17-Dec-2014
	New Product on qualified process and qualified package		•	ECD for Conditional:
				Job ECD: 19-Mar-2015

Completed Tasks

1.0 Lot AER2243 AssemblyLo	ot AER2243	DateCode	1504	
Seq TaskCode	SampleSize	Criteria	Complete Failures	DataSource Results/Comments
1 Data-Prep	None	None	19-Feb-2015	Camarillo
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	20-Feb-2015 0	Camarillo
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	27-Feb-2015 0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	19-Feb-2015 0	Camarillo
5 HTRB_150°C_0072	105	Pass on Zero Fails	23-Feb-2015 0	Camarillo
6 HTRB_150°C _0408	105	Pass on Zero Fails	06-Mar-2015 0	Camarillo
7 85/85_Pre Elec	20	Pass on Zero Fails	19-Feb-2015 0	Camarillo
8 85/85_120hr_On/Off	20	Pass on Zero Fails	24-Feb-2015 0	Camarillo
9 Pack_Clos	0	0	09-Mar-2015	Camarillo

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